Power MOSFET

60 V, 24 m Ω , Single N–Channel, µ8FL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Designs
- Low Q_{G(TOT)} to Minimize Switching Losses
- Low Capacitance to Minimize Driver Losses
- These are Pb–Free Devices

Applications

- Motor Drivers
- DC-DC Converters
- Synchronous Rectification
- Power Management

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

-			· · · ·	-	
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	60	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain		$T_{mb} = 25^{\circ}C$	۱ _D	20	А
Current $R_{\Psi J-mb}$ (Notes 1, 2, and 3)		$T_{mb} = 100^{\circ}C$		14	
Power Dissipation	Steady State	T _{mb} = 25°C	PD	19	W
$R_{\Psi J-mb}$ (Notes 1, 2, and 3)		T _{mb} = 100°C		10	
Continuous Drain		T _A = 25°C	۱ _D	8	А
Current $R_{\theta JA}$ (Notes 1 & 3)		T _A = 100°C		6	
Power Dissipation		T _A = 25°C	PD	3.1	W
$R_{\theta JA}$ (Notes 1 & 3)		$T_A = 100^{\circ}C$		1.6	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	133	А
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to 175	°C
Source Current (Body Diode)			I _S	20	А
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 50 V, V _{GS} = 10 V, $I_{L(pk)}$ = 14.4 A, L = 1.0 mH, R _G = 25 Ω)			E _{AS}	20	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	7.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	48	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

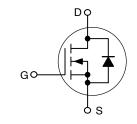


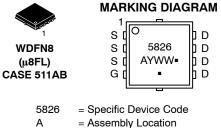
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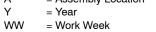
http://onsemi.com

V _{(BR)DSS}	V _{(BR)DSS} R _{DS(on)} MAX	
60 V	24 mΩ @ 10 V	20 A
	32 mΩ @ 4.5 V	207









= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS5826NLTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS5826NLTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

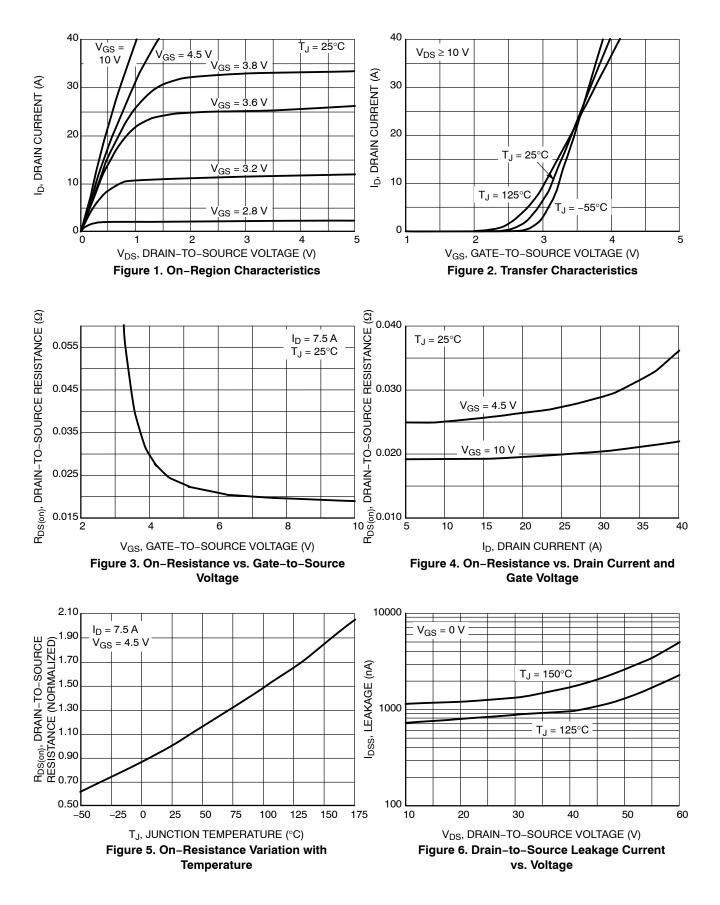
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

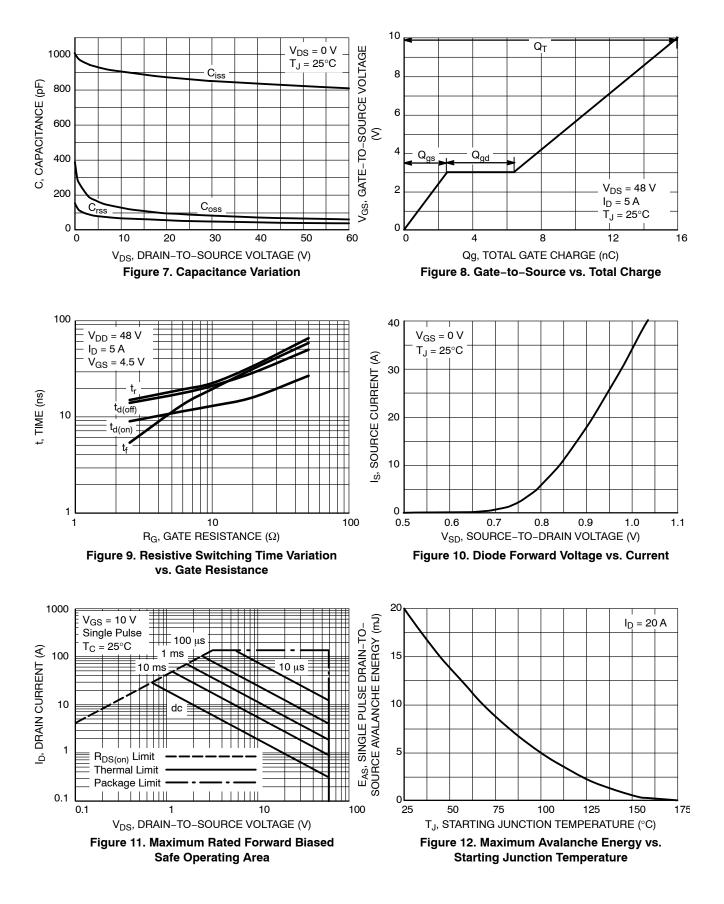
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				58.6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		V _{GS} = 0 V, V _{DS} = 60 V	$T_J = 125^{\circ}C$			10	1
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D =	= 250 μA	1.5		3.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 7.5 A		19	24	mΩ
		V _{GS} = 4.5 V	I _D = 7.5 A		25	32	
Forward Transconductance	9 FS	V _{DS} = 15 V, I _D = 5.0 A			8		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE					
Input Capacitance	C _{iss}				850		pF
Output Capacitance	C _{oss}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 25 V			85		-
Reverse Transfer Capacitance	C _{rss}				50		
Total Gate Charge	Q _{G(TOT)}				8.4		nC
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 4.5 V, V_{DS} = 48 V, I_D = 5.0 A			1		1
Gate-to-Source Charge	Q _{GS}				2.5		1
Gate-to-Drain Charge	Q _{GD}				3.9		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48V, I _D = 5.0A			16	25	nC
Gate Resistance	R _G	$T_A = 25^{\circ}C$			1.5		Ω
SWITCHING CHARACTERISTICS (No	ote 5)						
Turn-On Delay Time	t _{d(on)}				9		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS}	s = 48 V.		15		1
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = 5.0 \text{ A}, \text{ R}_{\rm G} = 2.5 \Omega$			14		1
Fall Time	t _f				5.4		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS				•		
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.8	2.3	V
		I _S = 7.5 A	$T_J = 125^{\circ}C$		0.7]
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d _{IS} /d _t = 100 A/µs, I _S = 5.0 A			15		ns
Charge Time	t _a				12	1	1
Discharge Time	t _b				4	1	1
Reverse Recovery Charge	Q _{RR}				13		nC

 $\begin{array}{ll} \mbox{4. Pulse Test: pulse width = 300 μs, duty cycle $\le 2\%$.} \\ \mbox{5. Switching characteristics are independent of operating junction temperatures.} \end{array}$

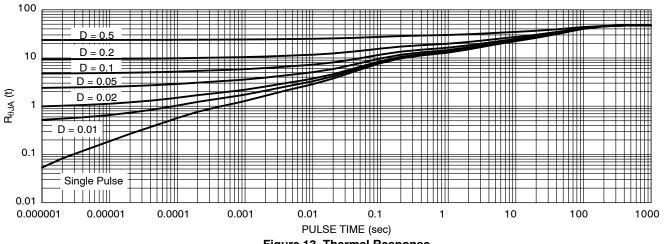
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



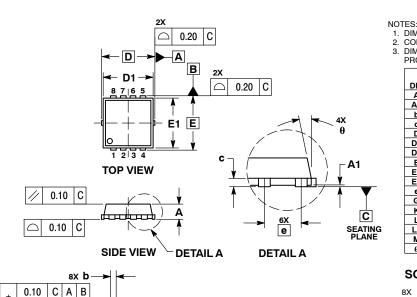
TYPICAL CHARACTERISTICS





PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB-01 ISSUE B



e/2

D2

BOTTOM VIEW

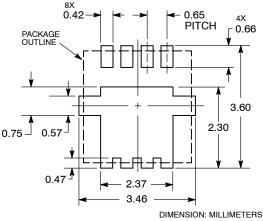
MILLIMETERS INCHES MAX MIN NOM MAX MIN NOM DIN Α 0.70 0.75 0.80 0.028 0.030 0.031 A1 0.00 0.05 0.000 0.002 0.016 0.23 0.30 0.40 0.009 0.012 b 0.15 0.20 0.25 0.006 0.008 0.010 c D 30 BSC 0.130 BSC D1 0.116 0.120 2.95 3.15 0.124 3.05 D2 1.98 2.11 0.078 0.083 2.24 0.088 E .30 BS 0.130 BS E1 0.116 0.120 2.95 3.15 0.124 3.05 E2 1.47 1.60 0.058 0.063 0.068 1.73 0.65 BS e G 0.026 BS 0.30 0.51 0.020 0.41 0.012 0.016 κ 0.025 0.64 0.43 0.56 0.012 0.017 0.022 L 0.30 L1 M 0.06 0.13 0.20 0.002 0.005 0.008 1.40 1.50 1.60 0.055 0.059 0.063 0 12 ° 0 12

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH

PROTRUSIONS OR GATE BURRS.

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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